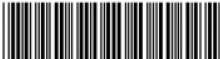


<b>Search Notes</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10723364	LEE ET AL.
Examiner	Art Unit	
Rajan, Kai	3736	

### SEARCHED

Class	Subclass	Date	Examiner
600	300,301	2/2008	KR

### SEARCH NOTES

Search Notes	Date	Examiner
Search Updated	2/2008	KR

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner